ECE 656 Homework (Week 6) Mark Lundstrom Purdue University

- 1) We have discussed M(E) for a 3D semiconductor with parabolic energy bands. Answer the following two questions about a 3D semiconductor with non-parabolic energy bands.
 - a) Assume that the non-parabolicity can be described by

$$E(1+\alpha E) = \frac{\hbar^2 k^2}{2m^*(0)}$$

Derive an expression for the corresponding M(E).

b) Using the following numbers for GaAs, $m^*(0) = 0.067 m_0$

$$\alpha = 0.64$$
 ,

plot M(E) from the bottom of the Γ valley to E = 0.3 eV comparing results from the non-parabolic expression derived in part a) to the parabolic expression.

2) The figure below shows a semiconductor with the Fermi level located in five different locations. If we use the Landauer expression to compute the current:

$$I = \left(2q/h\right) \int_{E_1}^{E_2} \mathcal{T}(E) M(E) (f_1 - f_2) dE$$

what are appropriate limits of integration, E_1 and E_2 , for each case? You may assume room temperature and a bandgap of 1 eV and that $E_{F1} \approx E_{F2} \approx E_F$.



3) Determine the limits of integration, E_1 and E_2 , for the integral in the Landauer expression:

$$I = \left(\frac{2q}{h}\right) \int_{E_1}^{E_2} \mathcal{T}(E) M(E) (f_1 - f_2) dE$$

for the case of T = 0 K. Assume that contact one is grounded and that a positive voltage (not necessarily small) has been applied to contact 2.

4) The ballistic conductance is often derived from a k-space treatment, which writes the current from left to right as

$$I^+ = \frac{1}{L} \sum_{k>0} q \upsilon_x f_0 \left(E_{F1} \right)$$

and the current from right to left as

$$I^- = \frac{1}{L} \sum_{k<0} q \upsilon_x f_0 \left(E_{F2} \right)$$

The net current is the difference between the two. In the ballistic limit, the Landauer expression for the current is

$$I = (2q/h) \int_{E_1}^{E_2} M(E) (f_1 - f_2) dE$$

- 4a) Assume parabolic energy bands, evaluate the net current from the k-space approach, and show that it is the same as the Landauer expression.
- 4b) Assume parabolic energy bands, but now assume **2D electrons**. Evaluate the net current from the k-space approach, and show that it is the same as the Landauer expression.
- 4c) Assume parabolic energy bands, but now assume 3D electrons. Evaluate the net current from the k-space approach, and show that it is the same as the Landauer expression.

5) The quantity,

$$\langle M \rangle = \int_{E_c}^{\infty} M(E) \left(-\frac{\partial f_0}{\partial E} \right) dE$$

is the number of conduction band channels in the Fermi-Window. Answer the following questions.

- 5a) Evaluate $\langle M \rangle$ for an arbitrary temperature and location of the Fermi level assuming a 2D semiconductor with parabolic energy bands.
- 5b) Evaluate $\langle M \rangle$ for an arbitrary temperature and location of the Fermi level above the Dirac point, E_p , assuming graphene.
- 5c) Assume that $E_F = E_C + 0.1 \text{ eV} = E_D + 0.1 \text{ eV}$. For 5a), assume Si with $m^* = 0.19m_0$ and a valley degeneracy of 2. For 5b), assume graphene parameters, $v_F = 10^8$ cm/s and a valley degeneracy of 2. Compare the numerical values of $\langle M \rangle$ for these two cases assuming T = 300 K.
- 6) For a 3D diffusive resistor, we relate the current density to the electric field by

 $\mathcal{E}_{x} = \rho_{3D} J_{x} V/m$,

where \mathcal{E}_x is the electric field in V/m and J_x is the current density in A/m². Write the corresponding equations in 1D and 2D and determine the units of ρ_{1D} , $\rho_{2D} = \rho_s$, and ρ_{3D} .

7) The general expression for conductance,

$$G = \frac{2q^2}{h} \int \mathcal{T}(E) M(E) \left(-\frac{\partial f_0}{\partial E} \right) dE,$$

can be written as

$$G = \frac{2q^2}{h} \left\langle \left\langle \mathcal{T}(E) \right\rangle \right\rangle \left\langle M(E) \right\rangle.$$

For a 3D resistor in the diffusive limit,

$$G_{3D} = \frac{2q^2}{h} \left\langle \left\langle \lambda(E) \right\rangle \right\rangle \left\langle M(E) / A \right\rangle \frac{A}{L}.$$

Derive the general expressions for $\langle M(E)/A \rangle$ and for $\langle \langle \lambda(E) \rangle \rangle$ in terms of their energy-dependent quantities, M(E) and $\lambda(E)$. HINT: Begin at the ballistic limit and determine $\langle M(E)/A \rangle$ first.

- 8) According to equ. (6.9) on p. 182 of *Advanced Semiconductor Fundamentals*, 2nd Ed., (R.F. Pierret, 2003) the mobility of electrons in bulk Si for $N_D = 10^{14}$ cm⁻³ at T = 300 K is 1268 cm²/V-s and at $N_D = 10^{20}$ cm⁻³ it is 95 cm²/V-s. Assume an energy independent mean-free-path and **determine the mean-free-path**, λ_0 in both cases.
- 9) For solving problems involving 2D electrons in parabolic band semiconductors (i.e. as in the channel of a transistor), we can use the result in Lundstrom and Jeong, Appendix, p. 218, eqn. (A.30)

$$\sigma_{s} = \frac{2q^{2}}{h}\lambda_{0}\frac{\sqrt{2m^{*}k_{B}T}}{\pi\hbar}\Gamma\left(r+\frac{3}{2}\right)\mathcal{F}_{r-1/2}\left(\eta_{F}\right)$$

where *r* is the characteristic exponent for scattering,

$$\lambda(E) = \lambda_0 \left[\left(E - E_C \right) / k_B T \right]^r.$$

Use this expression and answer the following two questions.

9a) Assume a constant mfp,

$$\lambda(E) = \lambda_0$$
 (i.e. $r = 0$)

and **work out** an expression for the 2D mobility in terms of the mfp. Your results should be valid for any level of carrier degeneracy. **Simplify** your results for T = 0K and for non-degenerate conditions.

9b) Assume a "power law" mfp describe by

$$\lambda \left(E - E_C \right) = \lambda_0 \left[\left(E - E_C / k_B T \right) \right]^r,$$

where "*r*" is a characteristic exponent that describes scattering. Repeat problem 4a) for this energy-dependent mfp. **Note:** for T = 0 K, only one energy matters, so it is best just to write $\lambda(E)$ and not use the power law form.

- 10) Assume an n-channel MOSFET at T = 300 K with $n_s = 10^{13}$ cm⁻³. Assume that only the lowest subband is occupied and compute $\langle M_{2D} \rangle$, the average number of modes in the Fermi window per micrometer of channel width.
- 11) In 1D, we express the resistance of a long (diffusive) resistor by $R_{1D} = (1/\sigma_{1D})L$. In 2D, we write $R_{2D} = (1/\sigma_{2D})L/W$ and in 3D $R_{3D} = (1/\sigma_{3D})L/A$. Assuming a degenerate conductor (i.e. T = 0 K), begin with $G_{ball} = \frac{2q^2}{h}M(E_F)$ and develop expressions for the 1D, 2D, and 3D "ballistic conductivities."
- 12) One can derive a near-equilibrium current equation for a 2D, n-type conductor in the diffusive limit and write it as $J_n = \sigma_s d(F_n/q)/dx$ A/m. Derive the corresponding equation for a p-type semiconductor.
- 13) Begin with $J_{nx} = \sigma_n d(F_n/q)/dx$ and derive the drift-diffusion equation for a 3D n-type semiconductor with parabolic energy bands. **Do not** assume Maxwell-Boltzmann statistics.

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ECE 656 Homework (Week 6) (continued)

14) When we write the resistance as $R = R_{ball} (1 + L/\lambda_0)$, we assume a constant (energyindependent) mean-free-path. What is the corresponding expression for an energy dependent mean-free-path, $\lambda(E)$? Is a plot of resistance vs. length of the resistor a straight line?